Amendments to the Claims:

This listing of claims will replace all prior versions, and listings, of claims in the application:

Listing of Claims:

- 1. (Currently Amended) A bipolar transistor, comprising:
- a first semiconductor region of a first conductivity type defining a collector region;
- a second semiconductor region of a second conductivity type defining a base region;
- a third semiconductor region of said first conductivity type defining a emitter region; and
 - a metal layer providing contacts to said base and emitter regions;

wherein the transistor has a specific area resistance less than $\frac{500 \text{mQhms mm}^2}{300 \text{mOhms mm}^2}$;

and

wherein said metal layer has a thickness greater than $3\mu m$.

- 2. (Original) A bipolar transistor according to claim 1, wherein the metal layer has a thickness no less than $4\mu m$.
- (Previously Presented) A bipolar transistor according to, claim 1 wherein the metal layer has a thickness no less than 6μm.
- 4. (Previously Presented) A bipolar transistor according to, claim 1 wherein the emitter region defines a first surface, the base region extending to said surface in locations defined by apertures through emitter region, said metal layer overlying said first surface.
- 5. (Original) A bipolar transistor according to claim 4, wherein adjacent apertures are spaced less than $100\mu m$ from each other.
 - 6. (Canceled)

- 7. (New) The bipolar transistor according to claim 1, wherein an increase in the thickness of the metal layer corresponds to a reduction in a voltage drop in the contacts to said base and emitter regions.
- 8. (New) The bipolar transistor according to claim 7, wherein the reduction in the voltage drop in the contacts is proportional to the increase in the thickness of the metal layer.